

<b>Notice of References Cited</b>	Application/Control No. 10/743,130	Applicant(s)/Patent Under Reexamination YOSHIKAWA ET AL.	
	Examiner Tianjie Chen	Art Unit 2627	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,715,121	02-1998	Sakakima et al.	360/324.2
*	B	US-6,839,206 B2	01-2005	Saito et al.	360/324.2
*	C	US-2003/0137783 A1	07-2003	Kokado, Satoshi	360/324.2
*	D	US-2003/0026048 A1	02-2003	Yamanaka et al.	360/324.2
*	E	US-2002/0164828 A1	11-2002	Ishiwata et al.	438/3
*	F	US-6,606,781 B1	08-2003	Gill, Hardayal Singh	29/603.08
*	G	US-6,347,049 B1	02-2002	Childress et al.	365/173
*	H	US-6,178,074 B1	01-2001	Gill, Hardayal Singh	360/324.2
*	I	US-5,636,093	06-1997	Gijs et al.	360/126
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.